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Room-temperature organic-based spin polarizer

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We report a magnetic tunnel junction operating at room-temperature with organic magnetic semiconductor V[TCNE]x (x ~ 2, TCNE: tetracyanoethylene) and Fe as the spin polarizer and analyzer while 10 nm rubrene layer serves as the tunnel barrier between them. At room-temperature, the magnetoresistance (MR) presents 16.7% of its peak value at 100 K. We observed sign inversion of MR with increasing temperature, while the sign of the MR is independent of the polarity of the bias voltages. Our results suggest that V[TCNE]x is a promising material for room-temperature spintronic applications. © 2011 American Institute of Physics. [doi:10.1063/1.3651329]

Recently, spin injection and detection in carbon-based materials have been a focus of attention, motivated by the long spin-relaxation time in these materials.1,2 Spin valves which consist of two magnetic layers with distinct coercivities decoupled by a spacer have often been used to demonstrate spin-polarized transport. Organic semiconductors have been employed as the spin transport layers or tunneling barriers, such as tris(8-hydroxyquinoline)-aluminum (Alq3) (Refs. 3–5) and rubrene (C42H28).6–8 However, there is a fundamental problem so-called “conductivity mismatch” for spin injection from ferromagnetic metals into semiconductors.9 The development of organic-based magnets is promising to provide a pathway to circumvent this problem.10 The combination of organic magnets and organic semiconductors will also be likely to give rise the next-generation lightweight, mechanically flexible and low-cost spintronic devices.

V[TCNE]x (x ~ 2, TCNE: tetracyanoethylene) with magnetic ordering temperature \(T_c \sim 400\) K is the first reported room-temperature organic-based magnet.11 The antiferromagnetic coupling between the \(V^{2+}\) ion’s three unpaired electrons in \(3d(t_{2g})\) orbitals and the \([TCNE]^–\) anion’s unpaired electron in \(\pi^*\) orbital gives rise to a net spin of \(S = 1/2\) for the repeat unit.12 The chemical structure of TCNE is shown in Figure 1(b). This material can be grown as a thin film by chemical vapor deposition (CVD) or molecular layer deposition (MLD).13,14 Optical detection of spin injection from V[TCNE]x into a GaAs/AlGaAs light-emitting diode has been realized.15 We have reported spin injection and detection using V[TCNE]x, both in a hybrid tunnel junction and an all-organic-based tunnel junction.16,17 However, the operation of the devices has been limited at low temperature, which is an obstacle for the development of practical applications. In this letter, we report experimental results on a V[TCNE]x-based spin valve operating up to room-temperature.

A spin valve is a sandwich device which consists of two ferromagnetic (FM) contacts with different coercivities separated by a nonmagnetic spacer. The device can switch between parallel and antiparallel magnetization configurations by sweeping an external magnetic field. In our experiments, V[TCNE]x and Fe were chosen as the two magnetic contacts of the spin valve, while rubrene acted as the tunnel barrier, as illustrated in Figure 1(a). We fabricated the spin valve by thermal evaporation using \(in\ situ\) shadow masks. To begin the device fabrication, glass substrates were cleaned ultrasonically and dried with nitrogen. Then organic solvent residue was removed by a UV-ozone cleaner. All the cleaning procedures were performed in a Class 1000 cleanroom. Right after the cleaning, the substrates were transferred into a vacuum chamber integrated in an argon glovebox for film depositions. The base pressure of the chamber was \(5 \times 10^{-7}\) Torr. 50 nm of Fe was deposited by e-beam evaporation at a rate of 0.2 Å/s. 10 nm of rubrene (chemical structure shown in Figure 1(c)) was deposited thermally using a Knudsen cell at a controlled temperature (~105 °C). We have reported that a single 5 nm rubrene layer was too thin to support the spin transport. In our experiments, V[TCNE]x and Fe were chosen as the two magnetic contacts of the spin valve, while rubrene acted as the tunnel barrier, as illustrated in Figure 1(a). We fabricated the spin valve by thermal evaporation using \(in\ situ\) shadow masks. To begin the device fabrication, glass substrates were cleaned ultrasonically and dried with nitrogen. Then organic solvent residue was removed by a UV-ozone cleaner. All the cleaning procedures were performed in a Class 1000 cleanroom. Right after the cleaning, the substrates were transferred into a vacuum chamber integrated in an argon glovebox for film depositions. The base pressure of the chamber was \(5 \times 10^{-7}\) Torr. 50 nm of Fe was deposited by e-beam evaporation at a rate of 0.2 Å/s. 10 nm of rubrene (chemical structure shown in Figure 1(c)) was deposited thermally using a Knudsen cell at a controlled temperature (~105 °C). We have reported that a single 5 nm rubrene layer was too thin to...
provide a uniform coverage or to form a good barrier. Lin et al. also reported that maximum tunneling thickness for rubrene is about 15 nm. The V[TCNE]₅ layer was grown by low temperature (~40°C) CVD with a thickness of about 300 nm. Another 30 nm of Al was deposited as the top contact. The effective junction area was 1 mm × 1 mm. The electric and magnetic measurements were performed in a physical property measurement system (PPMS) from Quantum Design with Keithley 2400 sourcemeter. The magnetic hysteresis loops were measured with a superconducting quantum interference device (SQUID).

Figure 2(a) shows the typical current-voltage (I-V) characteristics of the device at different temperatures, which are similar with the reported LSMO/LAO/rubrene/Fe magnetic tunnel junction. At low temperature and low bias voltage, the device current is dominated by tunneling through defect states in the energy gap. The carriers in these defect states could enter HOMO/LUMO levels via strong electric field as we increase the bias voltage, leading to the increase of the device current. At higher temperature, phonon interaction, such as phonon-assisted field emission, starts to play a role, giving rise to the temperature dependence. The absence of zero bias anomalies in the conductance vs bias plot (dI/dV vs V, see Figure 2(b)) suggests that the rubrene formed a good tunnel barrier, as discussed in literatures. Figure 3 shows the hysteresis loops of the two FM layers measured by SQUID separately. At 100 K, 50 nm Fe film has a coercive field of 160 Oe and V[TCNE]₅’s coercive field is about 5 Oe. The resistance of a spin valve varies depending on the relative alignment of the magnetization of the two FM layers. The magnetoresistance (MR) value is defined as $MR = (R_{AP} - R_P)/R_P$, where $R_{AP}$ and $R_P$ are the device resistance corresponding to antiparallel (AP) and parallel (P) configurations, respectively. The typical MR curves obtained from our devices are shown in Figure 4. At high applied magnetic field, the two FM layers align parallel with the external field. When the field reaches the coercive field of one of the FM layer, the device resistance has a sharp change as the two FM align antiparallel. The device showed negative MR at 100 K, which corresponds to lower device resistance for antiparallel alignment. The sign of the MR is independent of bias polarity. At 200 K, the MR is still clearly negative, as shown in Figure 5(a). Starting from 250 K, we can see a positive part contributing to the total MR. We have observed this
reported LSMO/rubrene/V[TCNE] increases linearly with increasing external magnetic field transport at high temperature. Our device kept showing spin explained by the increase of defect density and inelastic a common behavior for magnetic tunnel junction and can be 0.18% under 100 mV. The rapid decrease of MR value with small, it remains 16.7% of its peak value obtained at 100 K. The bias dependence of the MR values at 100 K is also pre-
tin junction, we have need to be developed to directly probe the interface between the ferromagnetic contact and the organic spacer. In our experiments, we observed the sign inversion of the MR as we varied the temperature, and the sign of MR was independent of polarity of bias voltage. Previously Vinzelberg et al. reported a MR sign inversion in dependence on the current in a LSMO/Alq3/Co device.23 The reason for the sign inversion is not clear yet.

In summary, we demonstrated a spin valve working at room-temperature using organic magnetic semiconductor V[TCNE] as the spin injector/detector. This result suggests that V[TCNE] could be one of the promising candidates for next-generation room-temperature spintronic applications. Future studies on the interface would provide more room for improvement of the device performance.

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